

Stability Analysis Using the R&S ZNL/ZNLE

Picotest NISM Software

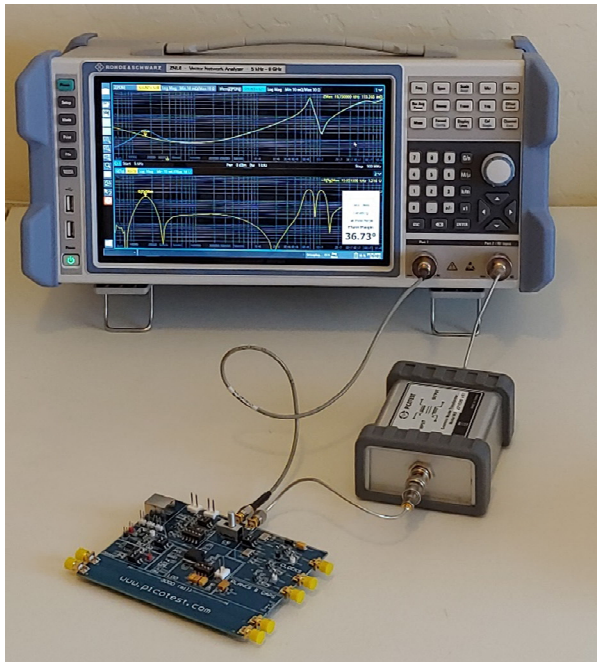
Identify the Stability/Phase Margin from an Output Impedance Measurement

Control loop stability is critical to the performance of all systems, as it influences all closed loop parameters, as well as system noise. Unfortunately, in many instances, particularly in the cases of voltage references, fixed voltage LDOs, and integrated POLs, a Bode plot assessment is not feasible because there is no feedback loop access to the part. In other cases, the feedback loop is difficult to access because the hardware is integrated or would require cutting a PCB trace. In yet other cases, the devices either contain multiple control loops, with only one of them being accessible, or the order of the control loop is higher than 2nd order, in which case the Bode plot is a poor predictor of relative stability. A further complication is that in many portable electronics, such as cell phones and tablets, the circuitry is very small and densely populated leaving little in the way of access to the control loop elements.

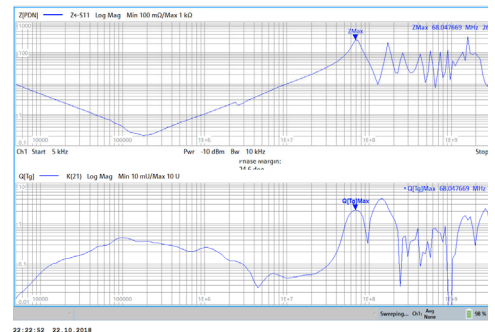
In these cases, the Non-Invasive Stability Margin ('NISM') assessment, which is derived from easily accessible output impedance measurements, is the only way to verify stability.

Since the stability is determined from an output impedance

measurement, made at the output of the power supply, you do not have to break the control loop in order to determine stability. This technique can be used with all types of power supplies including linear regulators, LDOs, POLs, VRMs, and DC-DC converters. Impedance can be tested using 1-port or 2-port measurements.



- Measure the stability margin of all types of control loops
- Support for 1-port and 2-port impedance measurements
- Ability to determine stability margin of regulators, switchers, POLs, and opamps, even if the control loop is not accessible or exposed outside of the device.
- Ability to find the phase margin of regulators and switchers that have multiple loops; even if one or more of those loops are internal to the device.

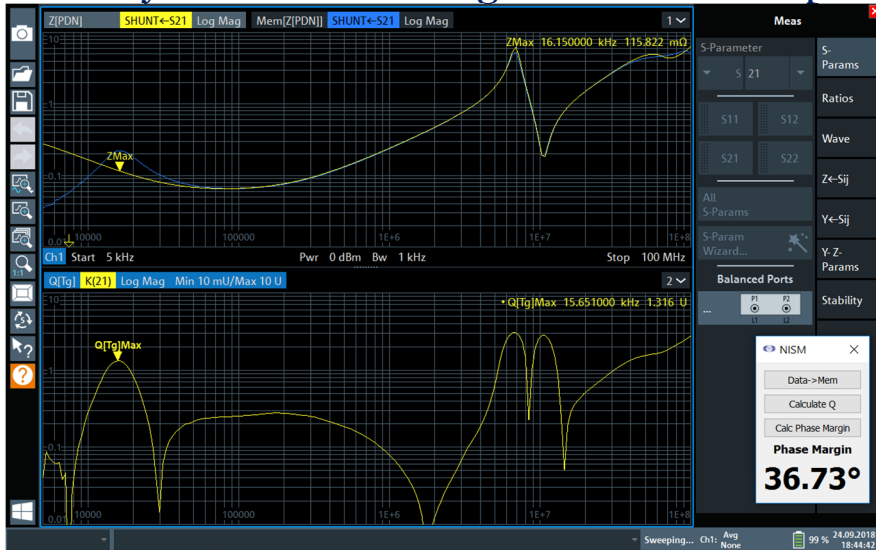


Testing the phase margin of a voltage reference using output impedance.

- Ability to derive the phase or stability margin from output impedance measurements
- NISM is supported on Rohde & Schwarz ZNL and ZNLE VNAs

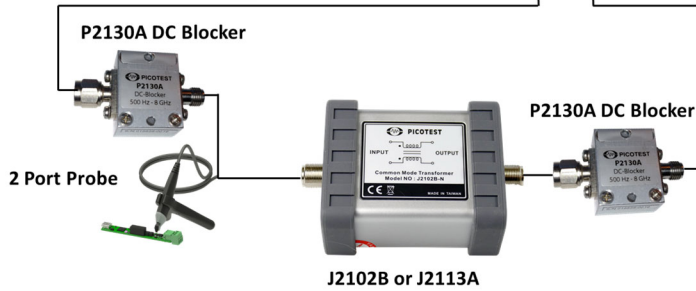


Stability without Breaking the Control Loop



The phase margin of an LDO is determined from an output impedance measurement on the Rohde & Schwarz ZNL VNA. Above the output impedance is shown along with the Q/Group Delay. From a simple cursor measurement and custom developed Picotest software, the stability is determined.

Rohde & Schwarz VNA ZNL6



Measurement setup to use the NISM software. The software needs to be installed in the ZNL after buying it from the Picotest website.

System Components

NISM Software	NISM Software (SINGLE USER License) for the Rohde and Schwarz ZNL and ZNLE
J2102B – Ground Loop Solution (BNC or N connectors)	Common Mode Transformer 3dB Bandwidth: 1Hz – 6GHz Maximum input voltage: 50V
J2113A – Ground Loop Solution	Semi-Floating Differential Amplifier 3dB Bandwidth: DC-800 MHz Maximum Input Voltage: 1.9V Typical CMRR - > 57dB
P21B01/P2130A DC Blocker	PDN Probe Bundle includes 1-Port and 2-Port 50 Ohm Transmission Line PDN Probes, Accessory Kit, and two P2130As

To learn more about this solution please contact



Picotest Solutions for Breaking the Ground Loop in 2-Port Measurements



J2102B Common Mode Transformer



J2113A Differential Amplifier

For information about Picotest Accessories for Rohde & Schwarz products, applications, and services, go to www.picotest.com

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